

Nine chip module test & beam test prep.

BIC Wafers, Modules & Staves Meeting

2026/2/2

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For the upcoming beam test

- Available AstroPix Setup
 - Single chip/ three quad-chips/ one nine-chip module
 - 1 GECCO+FPGA / 1 HV board+ASTEP board (one HV board and two(or three) ASTEP boards available)
 - V3 Single chip + GECCO / three layers of Quad-chips + ASTEP / nine-chip module + ASTEP
- Need more **HV board**: Sanghoon working on assembling HV boards and ASTEP boards.
- Only one ASTEP setup available, can we use this upcoming beam test?
- What's the limitation on our current ASTEP setup?
 - Readout speed, count rates (→ Good to discuss with Adrien and Dan)
- What's needed for the upcoming beam test? (short-term goal, FY2026)
- What's needed for the upcoming review? (long-term goal, FY2026)
 - Using RCDAQ, AstroPix (ASTEP) + Calorimeter (H2GCROC) → Synchronization!
 - AstroPix V3? V5?
 - AstroPix (ETC) ?
 - For v3? V5?
 - When is available? Can we use ETC for the upcoming beam test?
 - AstroLinx?
 - For v3? V5?
 - When is available? Can we use ETC for the upcoming beam test?

Why KEK beam test is important?

- Using three-layer of quad-chips
 - First aim to understand how AstroPix hit data are read out across chips and layers in a three-layer AstroPix system under the KEK beam condition (up to 2.3 kHz).
 - Since FPGA timestamps are assigned when AstroPix hit data arrives at the FPGA, I study whether hits across layers originate from the same particle using KEK beam test data.
 - Important step toward achieving precise synchronization with the calorimeter system in the upcoming beam test.
- Using three-layer of quad-chips with W plates placed between quad-chip layers
 - Observed that max buffer issues using three-layer of quad-chips with two W plates
 - Readout limitation about EM shower from electron beam
 - Need to improve readout speed
 - Chip-level design issue or ASTEP sw/fw issue?

Available AstroPix setup

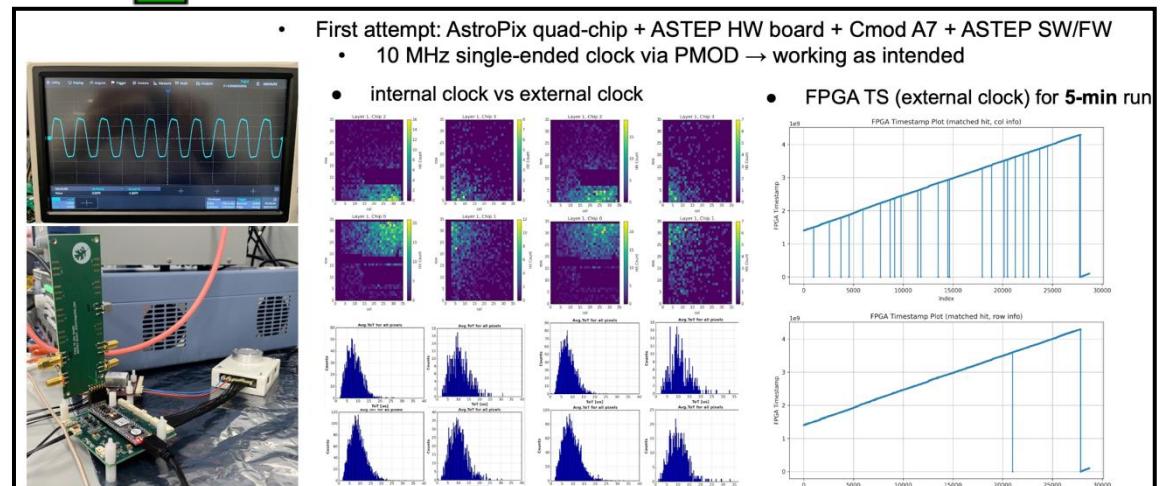
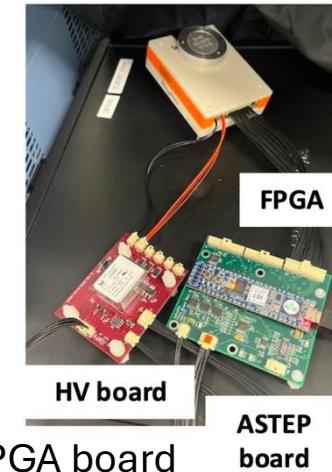
AstroPix

- Nine-chip Module
 - Only Module4 is working well.
 - Need to debug
 - Module1, 2, 3,  7, 8
- Quad-chip Module
 - Used in KEK beam test in Dec. 2025
 - W112q06
 - W101q04
 - W101q12(malfunctional chip0)
- Single chip
 - W06s01 (used in FNAL beam test in Jun. 2024)
 - W08s06

1. Test AstroPix using 40 MHz external clock
2. Test H2GCROC and AstroPix using 40 MHz external clock

GECCO / A-STEP setup

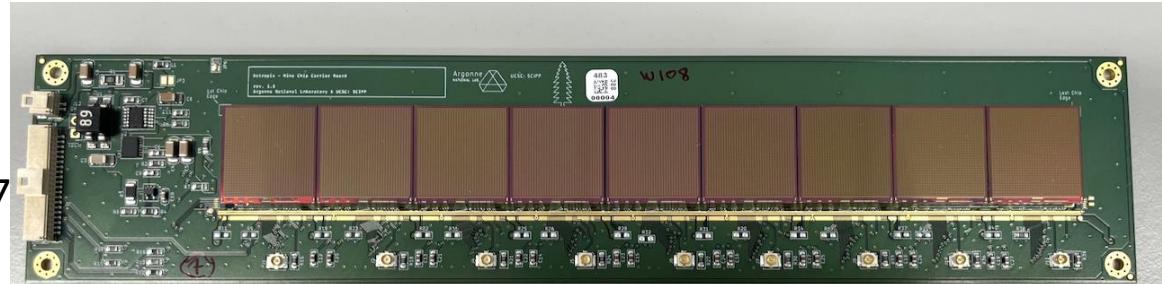
- 1 GECCO+FPGA board available
 - Running with v4 chip currently
 - External clock didn't work well.
- 1 A-STEP setup available
 - HV board + ASTEP board
 - Only one HV board available
 - Two ASTEP board available
 - One ASTEP board need to change FPGA board
 - Using external HV+ASTEP
 - Can't use it due to plenty of noise
 - External clock available



Current Status: Nine-chip module

- Module 4; working well.
 - After checking sampling clock (can be fixed with wire-bonding), configured up to 9 chips.
 - Last chip (chip8) is noisy and gives 0 ToT value (can be fixed with wire-bonding as well)
 - Mask maps Response to Sr-90 (for BIC review; Sep, 2025)
- Module 7; Not fully working yet but at least communication with PC and all AstroPix chips
 - After checking sampling clock (Jan 16, 2026);
 - Respond to the injection voltage
 - 0 ToT value: chip 2, 5, and 8
- Module 8; Need to check sampling clock!

Module 7



Module 8



Module 4



Previous nine-chip modules

- Three more previous boards: should check wire-bonding and pads on PCB
 - With Kapton underneath chips
 - Without Kapton underneath chips
- Previous issue was about applying HV

Module 1

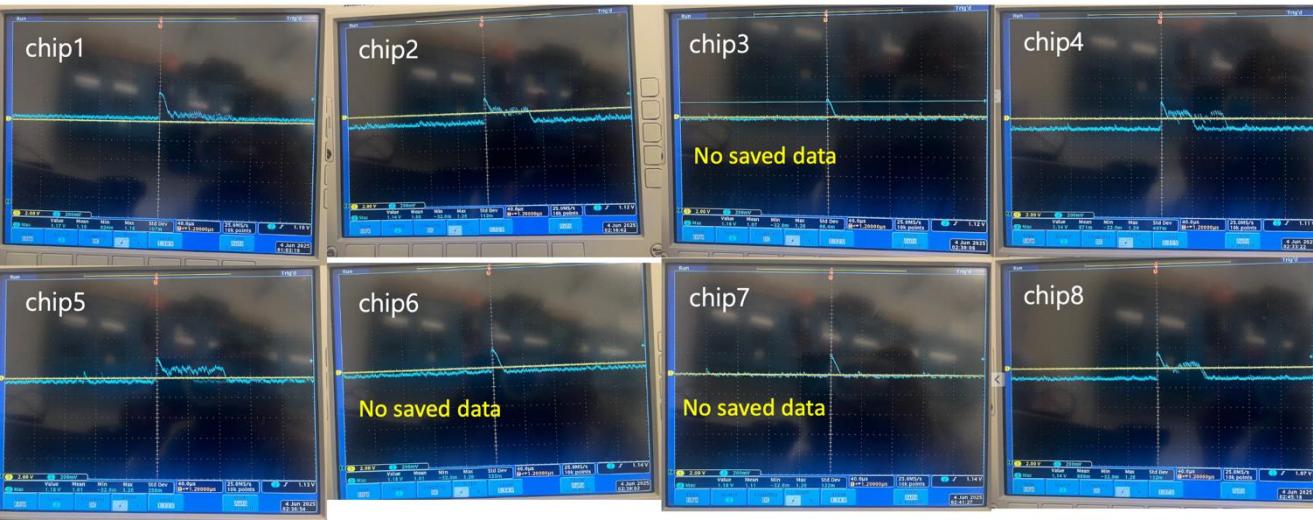


Module 2



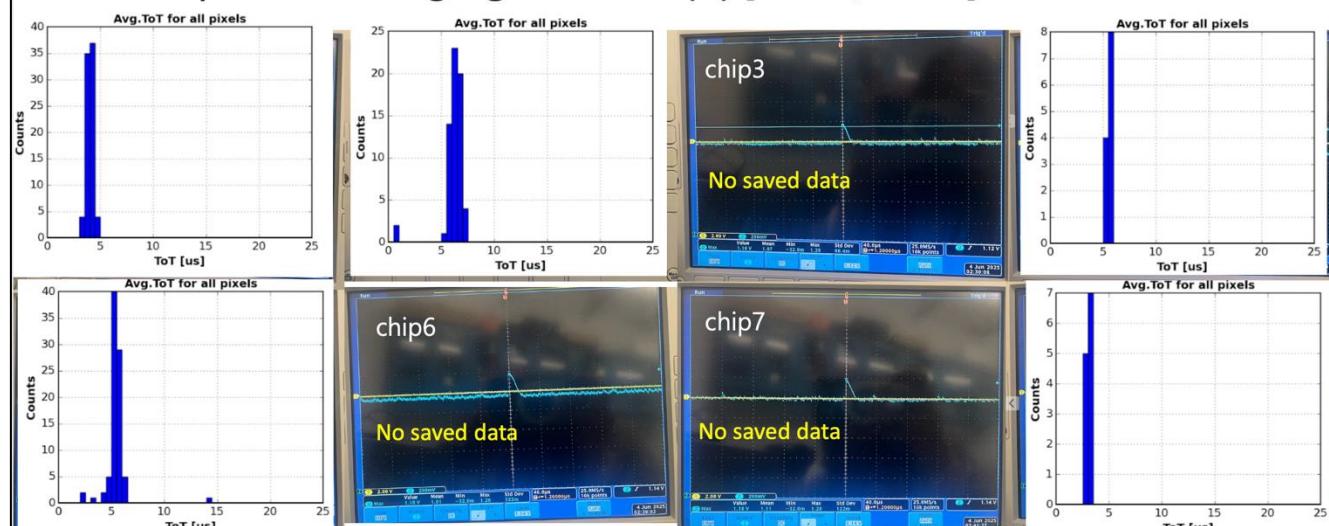
Module 3

9 chip PCB: Analog signal check (2) [col15, row0]



- Analog response plots for Chip 1–8, shown in order.
- Used threshold = 300 mV, Injection voltage = 600 mV

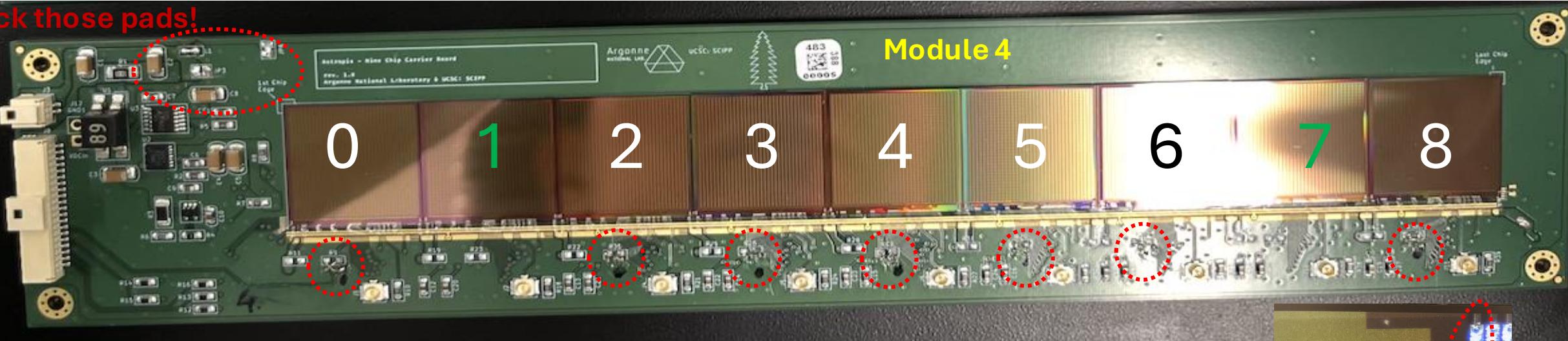
9 chip PCB: Analog signal check (3) [col15, row0]



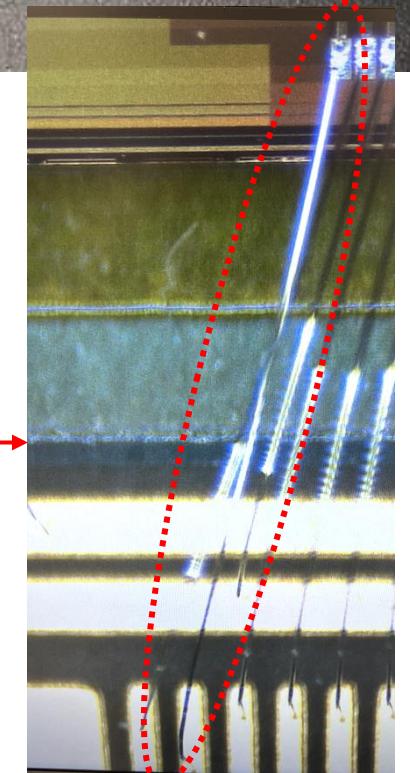
- Analog response plots for Chip 1–8, shown in order.
- Used threshold = 300 mV, Injection voltage = 600 mV

How to Modify Nine-Chip Module PCB (current version)

Check those pads!



- At PCB design level, the sampling clock pads have been swapped on **Chips 0, 2, 3, 4, 5, 6, and 8 (except 1 and 7)**.
 - In Module 4, the pad swap was implemented via additional soldering. (red circle)
 - After module 4, the pad swap on the assembled nine-chip boards was implemented via wire bonding.
 - The first and second sampling clock pads located in the middle of the chip.



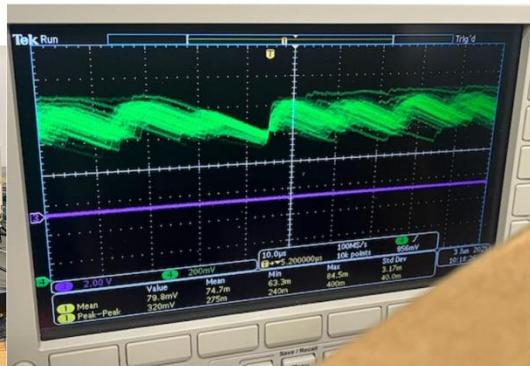
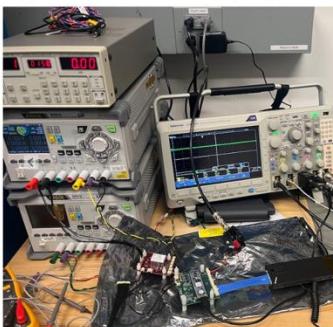
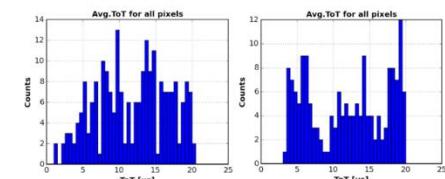
How to fix ToT value = 0 will be updated here

Issue using external HV

9 chip PCB: Analog signal check (1)

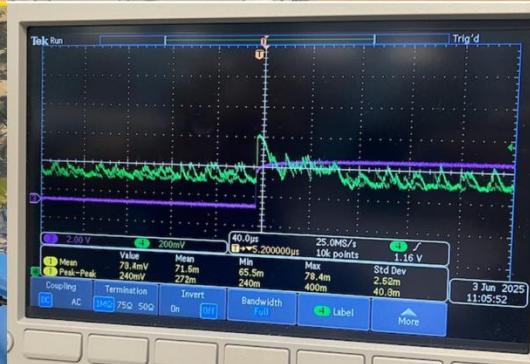
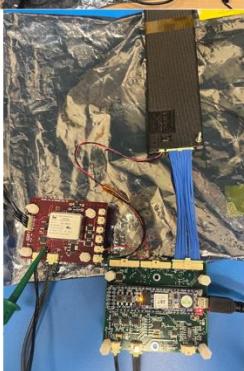
(top) external HV

- Unstable baseline: fluctuation ~ 300 mV
- Example of injection result ([All results](#))



(bottom) internal HV

- Still unstable baseline but improved compared to before.
- Injection to 9 chip PCB worked and corresponding analog signals were observed.
 - But the signal amplitude was smaller compared to single-chip or quad-chip result

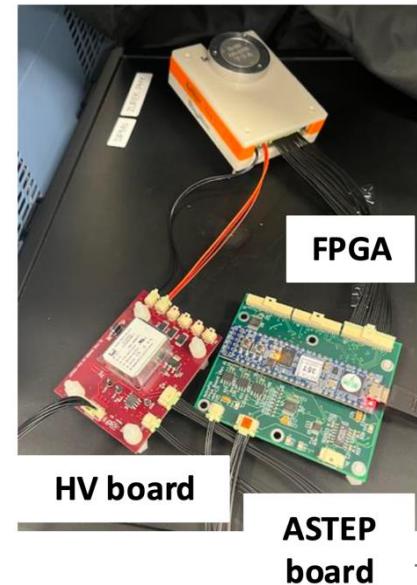


2025. 6. 11.

- Using HV board gives good results as expected.
 - Quad-chip/Nine-chip Module + HV board + A-STEP board setup
- **External HV** makes the max buffer issue.
 - Both quad-chip and nine-chip module
- Observed Quad-chip + GECCO setup didn't work; never got real data off of them with the gecco

→ Pretty sensitive to the grounding and having a separate HV supply with its own ground doesn't work well.

CAEN HV Supply



back up